

**Search Notes**

Application/Control No.

09/896,975

Examiner

Jacob Meek

Applicant(s)/Patent under  
Reexamination

CRUTCHFIELD ET AL.

Art Unit

2637

**SEARCHED**

Class	Subclass	Date	Examiner
375	359,293 288,257 289	11/23/2005	JM
178	69R	11/23/2005	JM
714	820,712	11/23/2005	JM
714	719	11/23/2005	JM
324	509,521	11/23/2005	JM
370	242	11/23/2005	JM

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East: see search notes	11/23/2005	JM
NPL	11/23/2005	JM